

Search Notes

Application/Control No.

10/728,529

Examiner

Jinhee J. Lee

Applicant(s)/Patent under
Reexamination

FUNAKI, TOMOYUKI

Art Unit

2174

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East text search attached	1/21/2007	LEE